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- Inputs Are TTL-Voltage Compatible
- EPIC™ (Enhanced-Performance Implanted CMOS) 1-µm Process
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), DIP (N) Packages, Ceramic Chip Carriers (FK), Flat (W), and DIP (J) Packages

#### description

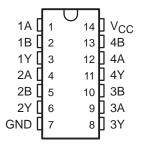
The 'ACT00 devices contain four independent 2-input NAND gates. Each gate performs the Boolean function of  $Y = \overline{A} \cdot \overline{B}$  or  $Y = \overline{A} + \overline{B}$  in positive logic.

The SN54ACT00 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The SN74ACT00 is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

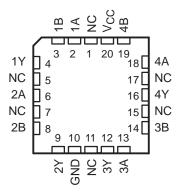
FUNCTION TABLE (each gate)

INP	UTS	OUTPUT
Α	В	Y
Н	Н	L
L	X	Н
Χ	L	Н

#### SN54ACT00 . . . J OR W PACKAGE SN74ACT00 . . . D, DB, N, OR PW PACKAGE (TOP VIEW)

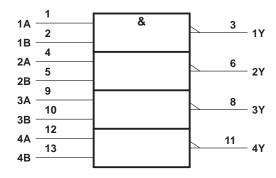


# SN54ACT00 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

## logic symbol†



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, DB, J, N, PW, and W packages.

## logic diagram, each gate (positive logic)





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# SN54ACT00, SN74ACT00 QUADRUPLE 2-INPUT POSITIVE-NAND GATES

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>		0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)		$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, VO (see Note 1)		$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ )		±20 mA
Output clamp current, IOK (VO < 0 or VO > VCC	.)	±20 mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ )		
Continuous current through V <sub>CC</sub> or GND		±200 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2):	D package	127°C/W
	DB package	158°C/W
	N package	78°C/W
	PW package	170°C/W
Storage temperature range, T <sub>sto</sub>		65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### recommended operating conditions (see Note 3)

		SN54A	CT00	SN74A	UNIT	
		MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		V
VIL	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	VCC	0	VCC	V
٧o	Output voltage	0	VCC	0	VCC	V
loh	High-level output current		- 24		- 24	mA
loL	Low-level output current		24		24	mA
Δt/Δν	Input transition rise or fall rate	0	8	0	8	ns/V
TA	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS	Vaa	T <sub>A</sub> = 25°C			SN54ACT00		SN74ACT00		UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	ONIT
Vон	I <sub>OH</sub> = - 50 μA	4.5 V	4.4	4.49		4.4		4.4		V
	ΙΟΗ = – 30 μΑ	5.5 V	5.4	5.49		5.4		5.4		
		4.5 V	3.86			3.7		3.76		
	I <sub>OH</sub> = – 24 mA	5.5 V	4.86			4.7		4.76		V
	I <sub>OH</sub> = -50 mA <sup>†</sup>					3.85				
	$I_{OH} = -75 \text{ mA}^{\dagger}$ 5.8							3.85		
	I <sub>OL</sub> = 50 μA	4.5 V		0.001	0.1		0.1		0.1	<b>&gt;</b>
	ΙΟΣ = 30 μΛ	5.5 V		0.001	0.1		0.1		0.1	
VOL	I <sub>OL</sub> = 24 mA	4.5 V			0.36		0.5		0.44	
VOL	IOL - 24 IIIA	5.5 V			0.36		0.5		0.44	
	$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V					1.65			
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V							1.65	
lį	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1		±1	μΑ
ICC	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			2		40		20	μΑ
Δl <sub>CC</sub> ‡	One input at 3.4 V, Other inputs at GND or V <sub>CC</sub>	5.5 V		0.6			1.6		1.5	mA
Ci	$V_I = V_{CC}$ or GND	5 V		2.6					·	pF

<sup>†</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	T <sub>A</sub> = 25°C		SN54ACT00		SN74ACT00		UNIT	
	(INPUT)		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH	A or B	V	1.5	5.5	9	1	9.5	1	9.5	ns
t <sub>PHL</sub>		ı	1.5	4	7	1	8	1	8	115

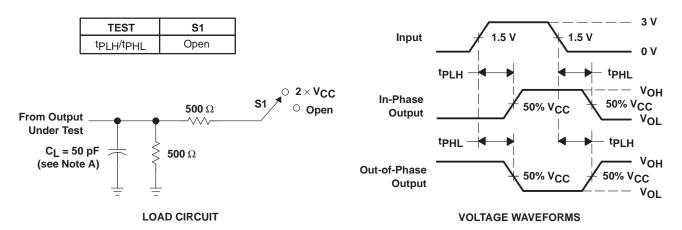
# operating characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

PARAMETER		TEST CO	TYP	UNIT	
C <sub>pd</sub> Power dissipation capacitance		C <sub>L</sub> = 50 pF,	f = 1 MHz	40	pF

<sup>‡</sup> This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or VCC.

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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq 2.5 \text{ ns.}$
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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